Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/696,151	CHENG ET AL.	
Examiner	Art Unit	
Matthew Landau	2815	

	SEARCHED					
Class	Subclass	Date	Examiner			
257	303	2/23/05	mk 1			
438	242					

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
	I				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST Search (printout included)	2/23/07	na	